TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74HC221AP, TC74HC221AF

#### **Dual Monostable Multivibrator**

The TC74HC221A is a high speed CMOS MONOSTABLE MULTIVIBRATOR fabricated with silicon gate  $\rm C^2MOS$  technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

There are two trigger inputs, A input (negative edge), and B input (positive edge). These inputs are valid for a slow rise/fall time signal (tr = tf = 1 s) as they are schmitt trigger inputs. This device may also be triggered by using  $\overline{CLR}$  input (positive edge).

After triggering, the output stays in a MONOSTABLE state for a time period determined by the external resistor and capacitor (Rx, Cx). A low level at the  $\overline{CLR}$  input breaks this state.

Limits for Cx and Rx are:

External capacitor, Cx: No limit

External resistor, Rx:  $V_{CC}$  = 2.0 V more than 5 k $\Omega$ 

 $VCC \ge 3.0 \text{ V more than } 1 \text{ k}\Omega$ 

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

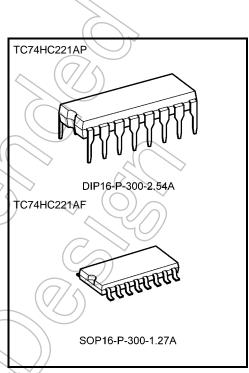
## Features (Note)

- High speed:  $t_{pd} = 25 \text{ ns (typ.)}$  at  $V_{CC} = 5V$
- Low power dissipation

Standy by State:  $I_{CC} = 4 \mu A \text{ (max)}$  at  $T_a = 25^{\circ}\text{C}$ Active State:  $I_{CC} = 700 \mu A \text{ (max)}$  at  $T_a = 25^{\circ}\text{C}$ 

- High noise immunity: VNIH = VNIL = 28% VCC (min)
- Output drive capability: 10/LSTTL loads
- Symmetrical output impedance: |IOH| = IOL = 4 mA (min)
- Balanced propagation delays: t<sub>p</sub>LH ≃ t<sub>p</sub>HL
- Wide operating voltage range:  $V_{CC}$  (opr) = 2 to 6 V
- Pin and function compatible with 74LS221

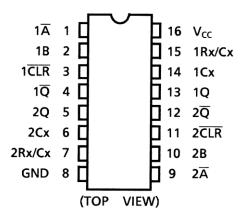
Note: In the case of using only one circuit,  $\overline{CLR}$  should be tied to GND,  $Rx/Cx \cdot Cx \cdot Q \cdot \overline{Q}$  should be tied to OPEN, the other inputs should be tied to VCC or GND.



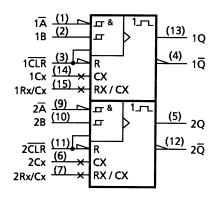
Weight

DIP16-P-300-2.54A : 1.00 g (typ.) SOP16-P-300-1.27A : 0.18 g (typ.)

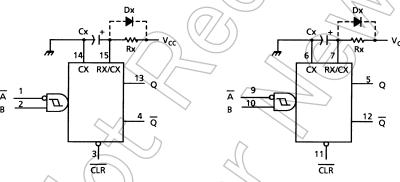
#### **Pin Assignment**



## **IEC Logic Symbol**



## **Block Diagram (Note)**



Note: Cx, Rx, Dx are external

capacitor, resistor, and diode, respectively.

Note: External clamping diode, Dx;

The external capacitor is charged to VCC level in the wait state, i.e. when no trigger is applied. If the supply voltage is turned off, Cx is discharges mainly through the internal (parasitic) diode. If Cx is sufficiently large and VCC drops rapidly, there will be some possibility of damaging the IC through in rush current or latch-up. If the capacitance of the supply voltage filter is large enough and VCC drops slowly, the in rush current is automatically limited and damage to the IC is avoided.

The maximum value of forward current through the parasitic diode is  $\pm 20$  mA.

In the case of a large Cx, the limit of fall time of the supply voltage is determined as follows:

$$tf \ge (VCC - 0.7) Cx/20 mA$$

(tf is the time between the supply voltage turn off and the supply voltage reaching 0.4 VCC.)

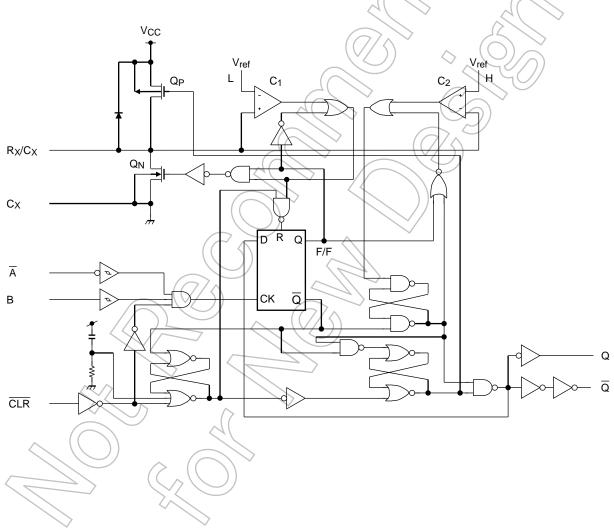
In the even a system does not satisfy the above condition, an external clamping diode (Dx) is needed to protect the IC from rush current.

# **Truth Table**

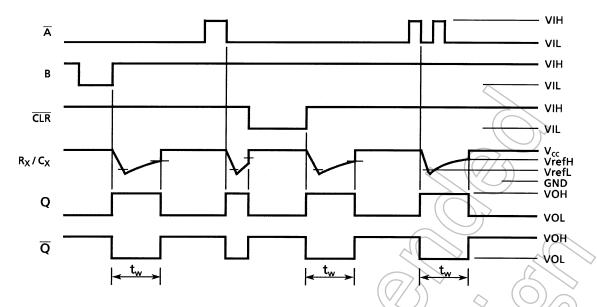
	Inputs		Out	puts	Note
Ā	В	CLR	Q	Ια	Note
$\neg$	Н	Н			Output Enable
Х	L	Η	L	Η	Inhibit
Н	Х	Н	L	Н	Inhibit
L		Н	Л	П	Output Enable
L	Н				Output Enable
Х	Х	L	L	Н	Reset

X: Don't care





#### **Timing Chart**



## **Functional Description**

(1) Stand-by state

The external capacitor (Cx) is fully charged to  $V_{CC}$  in the stand-by state. That means, before triggering, the QP and QN transistors which are connected to the Rx/Cx node are in the off state. Two comparators that relate to the timing of the output pulse, and two reference voltage supplies turn off. The total supply current is only leakage current.

(2) Trigger operation

Trigger operation is effective in any of the following three cases. First the condition where the  $\overline{A}$  input is low, and the B input has a rising signal; second, where the B input is high, and the  $\overline{A}$  input has a falling signal; and third, where the  $\overline{A}$  input is low and the B input is high, and the  $\overline{CLR}$  input has a rising signal.

After a trigger becomes effective, comparators C1 and C2 start operating, and QN is turned on. The external capacitor discharges through QN. The voltage level at the Rx/Cx node drops. If the Rx/Cx voltage level falls to the internal reference voltage Vref L, the output of C1 becomes low. The flip-flop is then reset and QN turns off. At that moment C1 stops but C2 continues operating.

After QN turns off, the voltage at the Rx/Cx node starts rising at a rate determined by the time constant of external capacitor Cx and resistor Rx.

Upon the triggering, output Q becomes high, following some delay time of the internal F/F and gates. It stays high even if the voltage of Rx/Cx changes from falling to rising. When Rx/Cx reaches the internal reference voltage Vref H, the output of C2 becomes low, the output Q goes low and C2 stops its operation. That means, after triggering, when the voltage level of the Rx/Cx node reaches Vref H, the IC returns to its MONOSTABLE state.

With large values of Cx and Rx, and ignoring the discharge time of the capacitor and internal delays of the IC, the width of the output pulse, twout, is as follows:

4

twout = 1.0 Cx Rx

(3) Reset operation

In normal operation,  $\overline{CLR}$  input is held high. If  $\overline{CLR}$  is low, a trigger has no effect because the Q output is held low and trigger control F/F is reset. Also, QP turns on and Cx is charge rapidly to VCC. This means if  $\overline{CLR}$  input is set low, the IC goes into a wait state.

#### **Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage range	Vcc	-0.5 to 7	V
DC input voltage	VIN	-0.5 to VCC + 0.5	V
DC output voltage	VOUT -0.5 to V <sub>CC</sub> +		V
Input diode current	lık	±20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V <sub>CC</sub> /ground current	Icc	±50	_mA
Power dissipation	PD	500 (DIP) (Note 1)/180 (SOP)	mW
Storage temperature	T <sub>stg</sub>	-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: 500 mW in the range of Ta = -40 to 65°C. From Ta = 65 to 85°C a derating factor of -10 mW/°C shall be applied until 300 mW.

## **Operating Ranges (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage	VCC	2 to 6	V
Input voltage	// \$VIN	0 to Vcc	V
Output voltage	Vout	0 to Vcc	V
Operating temperature	Topr	-40 to 85	°C
Input rise and fall time ( CLR only)	t <sub>r</sub> , t <sub>f</sub>	0 to 1000 (Vcc = 2.0 V) 0 to 500 (Vcc = 4.5 V) 0 to 400 (Vcc = 6.0 V)	ns
External capacitor	Cx	No limitation (Note 1)	F
External resistor	RX	≥ 5 k (V <sub>CC</sub> = 2.0 V) (Note 1) ≥ 1 k (V <sub>CC</sub> ≥ 3.0 V) (Note 1)	Ω

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Note 1 The maximum allowable values of Cx and Rx are a function of leakage of capacitor Cx, the leakage of TC74HC221A, and leakage due to board layout and surface resistance.

Susceptibility to externally induced noise signals may occur for  $Rx > 1 M\Omega$ .



# **Electrical Characteristics**

#### **DC Characteristics**

Characteristics	Symbol	Test Condition			7	Га = 25°C	)	Ta = -40 to 85°C		Unit	
Characteristics	Symbol			V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	Offic	
		_		2.0	1.50	— <	_	1.50	_		
High-level input voltage	VIH			4.5	3.15	_		3.15	_	V	
				6.0	4.20	_	$(\leftarrow)$	4.20	_		
Law law Law				2.0	_	-	0.50	<i>7</i> _	0.50		
Low-level input voltage	VIL	-	_	4.5	₹\	$+ \langle \rangle$	1,35	_	1.35	V	
			T	6.0	->	7//	1.80	_	1.80		
				2.0	1.9 (	2.0	> —	1.9	_		
High-level output		\/m.	IOH = -20 μA	4.5	4.4	4.5	_	4.4	_	V	
voltage	Voн	VIN = VIH or VIL		6.0	5.9	6.0	_	5.9	7		
(Q, Q)			IOH = -4 mA	4.5	4.18	4.31	-/	4.13	Ť		
			IOH = -5.2 mA	6.0	5.68	5.80	-((	5.63	< —		
	VoL	VIN = VIH or VIL	,	2.0	<i></i>	0.0	0.1	(4)	0.1		
Low-level output			IOL = 20 μA	4.5	_	0.0	0.1	50	0.1	V	
voltage —			40	6.0	_	0.0	0.1	_	0.1		
(Q, Q)			IOL = 4 mA	4.5	_	0.17	0.26	_	0.33		
			IOL = 5.2  mA	6.0	_	0.18	0.26	_	0.33		
Input leakage current	I <sub>IN</sub>	VIN = VCC or	GND	6.0		$))_{ }$	±0.1	_	±1.0	μΑ	
Rx/Cx terminal off-state current	lin	VIN = VCC of GND		6.0	\	)) <u> </u>	±0.1	_	±1.0	μΑ	
Quiescent supply current	Icc	VIN = VCC or GND		6.0	_	_	4.0	_	40.0	μΑ	
Active-state supply		VIN = VCC or GND Rx/Cx = 0.5 Vcc		2.0	\ -	45	200	_	260		
current	Icc'			4.5	<b>-</b>	400	500	_	650	μΑ	
(Note 1)		1,3,0x = 0.5 V		6.0	_	700	1000	_	1300		

Note 1: Per circuit

# Timing Requirements (input: tr = tf = 6 ns)

Characteristics	Symbol		Ta = 25°C		Ta = -40 to 85°C	Unit		
Characterionic	Cymbol	Test Condition	Vcc (V)	Тур.	Limit	Limit	J	
$\wedge$ (( ))	that (I)		2.0	_	75	95		
Minimum pulse width	tw (L)	_	4.5	_	15	19	ns	
	tw (H)		6.0		13	16		
			2.0		75	95		
Minimum clear width	tW (L)	_	4.5	_	15	19	ns	
			6.0	_	13	16		



# AC Characteristics (CL = 15 pF, VCC = 5 V, Ta = 25°C, input: tr = tf = 6 ns)

Characteristics	Symbol	Test Condition		Тур.	Max	Unit
Output transition time	tTLH			4	8	ne
Output transition time	tTHL	_	_	4	0	ns
Propagation delay time	tpLH			25	36	no
$(\overline{A}, B-Q, \overline{Q})$	tpHL	_		23	30	ns
Propagation delay time	t <sub>pLH</sub>			) 25	41	no
$(\overline{\text{CLR}} \text{ TRIGGER-Q}, \overline{\overline{\text{Q}}})$	tpHL	_		) 23	41	ns
Propagation delay time	t <sub>pLH</sub>	< (V		16	27	
$(\overline{CLR}-Q,\ \overline{Q})$	tpHL	_		16	21	ns





## AC Characteristics (CL = 50 pF, input: tr = tf = 6 ns)

				7	Га = 25°C		Ta = −40 to 85°C		
Characteristics	Symbol	Test Condition	Vcc (V)	Min	Тур.	Max	Min	Max	Unit
	tTLH		2.0	_	30	75	_	95	
Output transition time		_	4.5	_	8	15	_	19	ns
	tTHL		6.0	_	7	13	_	16	
Propagation delay time	tpLH		2.0	_	102	210	4	265	
$(\overline{A}, B-Q, \overline{Q})$	tpHL	_	4.5	_	30	42	<i>9</i> -	53	ns
,			6.0	_	24	36	_	45	
Propagation delay time	t <sub>pLH</sub>		2.0	->	102	235	_	295	
(CLR TRIGGER-Q, Q)	t <sub>pHL</sub>	_	4.5 6.0	_((	30	47 40	_	59 50	ns
,			2.0		67	160		200	
Propagation delay time	t <sub>pLH</sub>	_	4.5		20	32 /	D	40	ns
$(\overline{CLR}-Q,\ \overline{Q})$	t <sub>pHL</sub>	_	6.0	> <del>\</del>	16	27		> 34	113
	twouT	Cx = 28 pF	2.0	7	700	2000	14/	2500	
		$Rx = 6 k\Omega (V_{CC} = 2 V)$	4.5	_	250	400		500	ns
		$Rx = 2 k\Omega (V_{CC} = 4.5 V, 6 V)$	6.0	_	210	340	<b>~</b>	425	
		Cx = 0.01 μF Rx = 10 kΩ	2.0	90	110	_130	90	130	
Output pulse width			4.5	95	105	115	95	115	μs
			6.0	95	105	115	95	115	
		Cx = 0.1 µF	2.0	0.9	1.0	1.2	0.9	1.2	
		$Rx = 10 \text{ k}\Omega$	4.5	0.9	1.0	1.1	0.9	1.1	ms
		$KX = 10 \text{ K}\Omega$	6.0	0.9	1.0	1.1	0.9	1.1	
Output pulse width error between circuits (in same package)	Δtw <sub>OUT</sub>			_	±1	_	_	_	%
Input capacitance	CIN	$((//)$ - $\leq$	71/	_	5	10	_	10	pF
Power dissipation capacitance	CPD		(Note 1)	_	174	—	_	_	pF

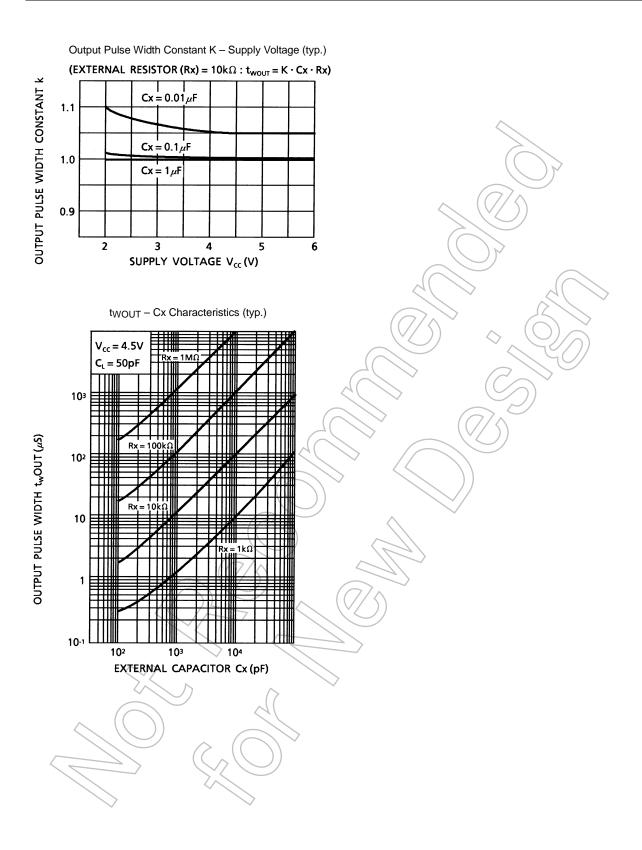
Note 1: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

ICC (opr) = CPD·VCC·fIN + ICC'·duty/100 + ICC/2 (per circuit)

(ICC': active supply current)

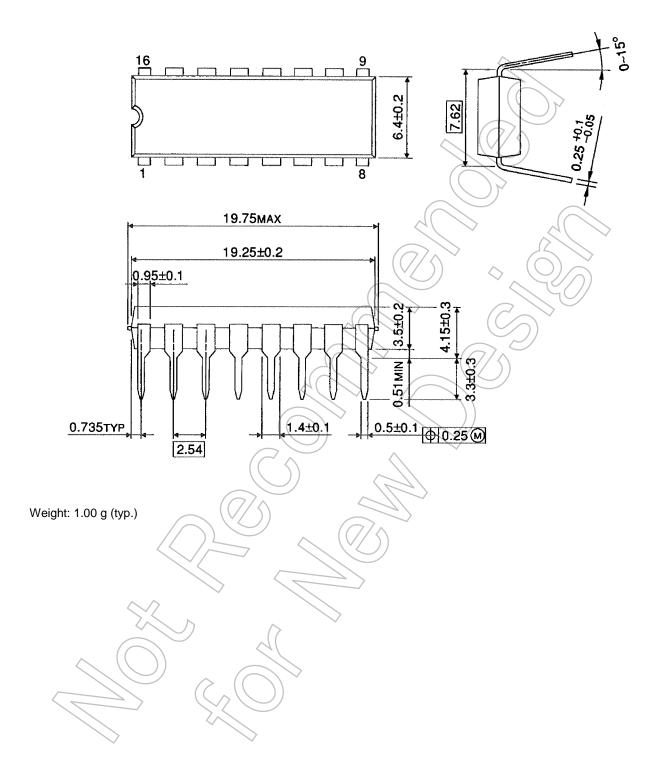
(duty: %)





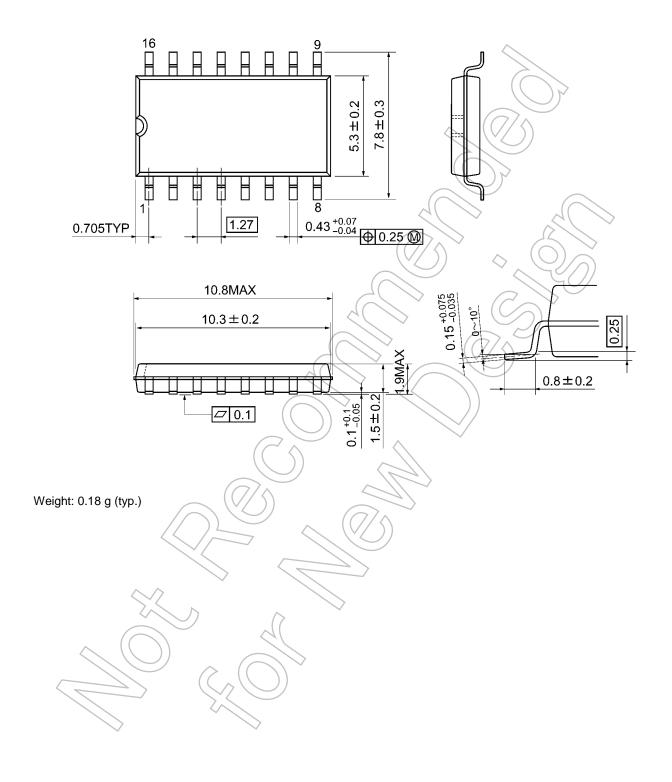
# **Package Dimensions**

DIP16-P-300-2.54A Unit: mm



# **Package Dimensions**

SOP16-P-300-1.27A Unit: mm



#### RESTRICTIONS ON PRODUCT USE

- Toshiba Corporation, and its subsidiaries and affiliates (collectively "TOSHIBA"), reserve the right to make changes to the information in this document, and related hardware, software and systems (collectively "Product") without notice.
- This document and any information herein may not be reproduced without prior written permission from TOSHIBA. Even with TOSHIBA's written permission, reproduction is permissible only if reproduction is without alteration/omission.
- Though TOSHIBA works continually to improve Product's quality and reliability, Product can malfunction or fail. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for their hardware, software and systems which minimize risk and avoid situations in which a malfunction or failure of Product could cause loss of human life, bodily injury or damage to property, including data loss or corruption. Before customers use the Product, create designs including the Product, or incorporate the Product into their own applications, customers must also refer to and comply with (a) the latest versions of all relevant TOSHIBA information, including without limitation, this document, the specifications, the data sheets and application notes for Product and the precautions and conditions set forth in the "TOSHIBA Semiconductor Reliability Handbook" and (b) the instructions for the application with which the Product will be used with or for. Customers are solely responsible for all aspects of their own product design or applications, including but not limited to (a) determining the appropriateness of the use of this Product in such design or applications; (b) evaluating and determining the applicability of any information contained in this document, or in charts, diagrams, programs, algorithms, sample application circuits, or any other referenced documents; and (c) validating all operating parameters for such designs and applications. TOSHIBA ASSUMES NO LIABILITY FOR CUSTOMERS' PRODUCT DESIGN OR APPLICATIONS.
- PRODUCT IS NEITHER INTENDED NOR WARRANTED FOR USE IN EQUIPMENTS OR SYSTEMS THAT REQUIRE
  EXTRAORDINARILY HIGH LEVELS OF QUALITY AND/OR RELIABILITY, AND/OR A MALFUNCTION OR FAILURE OF WHICH
  MAY CAUSE LOSS OF HUMAN LIFE, BODILY INJURY, SERIOUS PROPERTY DAMAGE AND/OR SERIOUS PUBLIC IMPACT
  ("UNINTENDED USE"). Except for specific applications as expressly stated in this document, Unintended Use includes, without
  limitation, equipment used in nuclear facilities, equipment used in the aerospace industry, medical equipment, equipment used for
  automobiles, trains, ships and other transportation, traffic signaling equipment, equipment used to control combustions or explosions,
  safety devices, elevators and escalators, devices related to electric power, and equipment used in finance-related fields. IF YOU USE
  PRODUCT FOR UNINTENDED USE, TOSHIBA ASSUMES NO LIABILITY FOR PRODUCT. For details, please contact your
  TOSHIBA sales representative.
- Do not disassemble, analyze, reverse-engineer, alter, modify, translate or copy Product, whether in whole or in part.
- Product shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any
  applicable laws or regulations.
- The information contained herein is presented only as guidance for Product use. No responsibility is assumed by TOSHIBA for any infringement of patents or any other intellectual property rights of third parties that may result from the use of Product. No license to any intellectual property right is granted by this document, whether express or implied, by estoppel or otherwise.
- ABSENT A WRITTEN SIGNED AGREEMENT, EXCEPT AS PROVIDED IN THE RELEVANT TERMS AND CONDITIONS OF SALE
  FOR PRODUCT, AND TO THE MAXIMUM EXTENT ALLOWABLE BY LAW, TOSHIBA (1) ASSUMES NO LIABILITY
  WHATSOEVER, INCLUDING WITHOUT LIMITATION, INDIRECT, CONSEQUENTIAL, SPECIAL, OR INCIDENTAL DAMAGES OR
  LOSS, INCLUDING WITHOUT LIMITATION, LOSS OF PROFITS, LOSS OF OPPORTUNITIES, BUSINESS INTERRUPTION AND
  LOSS OF DATA, AND (2) DISCLAIMS ANY AND ALL EXPRESS OR IMPLIED WARRANTIES AND CONDITIONS RELATED TO
  SALE, USE OF PRODUCT, OR INFORMATION, INCLUDING WARRANTIES OR CONDITIONS OF MERCHANTABILITY, FITNESS
  FOR A PARTICULAR PURPOSE, ACCURACY OF INFORMATION, OR NONINFRINGEMENT.
- Do not use or otherwise make available Product or related software or technology for any military purposes, including without
  limitation, for the design, development, use, stockpiling or manufacturing of nuclear, chemical, or biological weapons or missile
  technology products (mass destruction weapons). Product and related software and technology may be controlled under the
  applicable export laws and regulations including, without limitation, the Japanese Foreign Exchange and Foreign Trade Law and the
  U.S. Export Administration Regulations. Export and re-export of Product or related software or technology are strictly prohibited
  except in compliance with all applicable export laws and regulations.
- Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product.
  Please use Product in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. TOSHIBA ASSUMES NO LIABILITY FOR DAMAGES OR LOSSES
  OCCURRING AS A RESULT OF NONCOMPLIANCE WITH APPLICABLE LAWS AND REGULATIONS.

12 2016-12-02